



SEMITRANS® 3

## Trench IGBT Modules

### SKM300GB07E3

#### Features\*

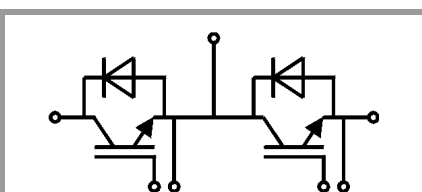
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability, self limiting to  $6 \times I_{Cnom}$
- Fast & soft inverse CAL diodes
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated gate resistor

#### Typical Applications

- AC inverter drives
- UPS

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$
- Use of soft  $R_G$  necessary



GB

| Absolute Maximum Ratings |                                                                                   |                         |             |      |      |      |
|--------------------------|-----------------------------------------------------------------------------------|-------------------------|-------------|------|------|------|
| Symbol                   | Conditions                                                                        |                         | Values      |      | Unit |      |
| IGBT                     |                                                                                   |                         |             |      |      |      |
| V <sub>CES</sub>         | T <sub>j</sub> = 25 °C                                                            |                         | 650         |      | V    |      |
| I <sub>C</sub>           | T <sub>j</sub> = 175 °C                                                           | T <sub>c</sub> = 25 °C  | 394         |      | A    |      |
|                          |                                                                                   | T <sub>c</sub> = 80 °C  | 297         |      | A    |      |
| I <sub>Cnom</sub>        |                                                                                   |                         | 300         |      | A    |      |
| I <sub>CRM</sub>         | I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>                                          |                         | 900         |      | A    |      |
| V <sub>GES</sub>         |                                                                                   |                         | -20 ... 20  |      | V    |      |
| t <sub>psc</sub>         | V <sub>CC</sub> = 360 V<br>V <sub>GE</sub> ≤ 15 V<br>V <sub>CES</sub> ≤ 650 V     | T <sub>j</sub> = 150 °C | 6           |      | μs   |      |
| T <sub>j</sub>           |                                                                                   |                         | -40 ... 175 |      | °C   |      |
| Inverse diode            |                                                                                   |                         |             |      |      |      |
| V <sub>RRM</sub>         | T <sub>j</sub> = 25 °C                                                            |                         | 650         |      | V    |      |
| I <sub>F</sub>           | T <sub>j</sub> = 175 °C                                                           | T <sub>c</sub> = 25 °C  | 335         |      | A    |      |
|                          |                                                                                   | T <sub>c</sub> = 80 °C  | 244         |      | A    |      |
| I <sub>Fnom</sub>        |                                                                                   |                         | 300         |      | A    |      |
| I <sub>FRM</sub>         | I <sub>FRM</sub> = 2xI <sub>Fnom</sub>                                            |                         | 600         |      | A    |      |
| I <sub>FSM</sub>         | t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C                          |                         | 2160        |      | A    |      |
| T <sub>j</sub>           |                                                                                   |                         | -40 ... 175 |      | °C   |      |
| Module                   |                                                                                   |                         |             |      |      |      |
| I <sub>t(RMS)</sub>      |                                                                                   |                         | 500         |      | A    |      |
| T <sub>stg</sub>         | module without TIM                                                                |                         | -40 ... 125 |      | °C   |      |
| V <sub>isol</sub>        | AC sinus 50 Hz, t = 1 min                                                         |                         | 4000        |      | V    |      |
|                          |                                                                                   |                         |             |      |      |      |
| Characteristics          |                                                                                   |                         |             |      |      |      |
| Symbol                   | Conditions                                                                        |                         | min.        | typ. | max. | Unit |
| IGBT                     |                                                                                   |                         |             |      |      |      |
| V <sub>CE(sat)</sub>     | I <sub>C</sub> = 300 A<br>V <sub>GE</sub> = 15 V<br>chipelevel                    | T <sub>j</sub> = 25 °C  | 1.45        | 1.90 |      | V    |
|                          |                                                                                   | T <sub>j</sub> = 150 °C | 1.69        | 2.10 |      | V    |
| V <sub>CE0</sub>         | chipelevel                                                                        | T <sub>j</sub> = 25 °C  | 0.90        | 1.00 |      | V    |
|                          |                                                                                   | T <sub>j</sub> = 150 °C | 0.82        | 0.90 |      | V    |
| r <sub>CE</sub>          | V <sub>GE</sub> = 15 V<br>chipelevel                                              | T <sub>j</sub> = 25 °C  | 1.83        | 3.0  |      | mΩ   |
|                          |                                                                                   | T <sub>j</sub> = 150 °C | 2.9         | 4.0  |      | mΩ   |
| V <sub>GE(th)</sub>      | V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 4.8 mA                        |                         | 5.1         | 5.8  | 6.4  | V    |
| I <sub>CES</sub>         | V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 650 V, T <sub>j</sub> = 25 °C            |                         |             |      | 0.3  | mA   |
| C <sub>ies</sub>         | V <sub>CE</sub> = 25 V<br>V <sub>GE</sub> = 0 V                                   | f = 1 MHz               | 18.5        |      |      | nF   |
| C <sub>oes</sub>         |                                                                                   | f = 1 MHz               | 1.16        |      |      | nF   |
| C <sub>res</sub>         |                                                                                   | f = 1 MHz               | 0.55        |      |      | nF   |
| Q <sub>G</sub>           | V <sub>GE</sub> = - 8 V...+ 15 V                                                  |                         | 2400        |      |      | nC   |
| R <sub>Gint</sub>        | T <sub>j</sub> = 25 °C                                                            |                         | 1.0         |      |      | Ω    |
| t <sub>d(on)</sub>       | V <sub>CC</sub> = 300 V<br>I <sub>C</sub> = 300 A<br>V <sub>GE</sub> = +15/-7.5 V | T <sub>j</sub> = 150 °C | 157         |      |      | ns   |
| t <sub>r</sub>           |                                                                                   | T <sub>j</sub> = 150 °C | 58          |      |      | ns   |
| E <sub>on</sub>          | R <sub>G on</sub> = 2 Ω<br>R <sub>G off</sub> = 5.6 Ω                             | T <sub>j</sub> = 150 °C | 4.7         |      |      | mJ   |
| t <sub>d(off)</sub>      |                                                                                   | T <sub>j</sub> = 150 °C | 813         |      |      | ns   |
| t <sub>f</sub>           | di/dt <sub>on</sub> = 6100 A/μs<br>di/dt <sub>off</sub> = 4500 A/μs               | T <sub>j</sub> = 150 °C | 67          |      |      | ns   |
| E <sub>off</sub>         | dv/dt = 1700 V/μs<br>L <sub>s</sub> = 22 nH                                       | T <sub>j</sub> = 150 °C | 13.6        |      |      | mJ   |
| R <sub>th(j-c)</sub>     | per IGBT                                                                          |                         | 0.15        |      |      | K/W  |
| R <sub>th(c-s)</sub>     | per IGBT (λ <sub>grease</sub> =0.81 W/(m²K))                                      |                         | 0.042       |      |      | K/W  |
| R <sub>th(c-s)</sub>     | per IGBT, pre-applied phase change material                                       |                         | 0.038       |      |      | K/W  |



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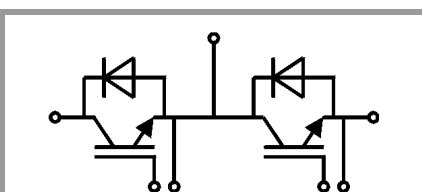
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#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
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| Characteristics                  |                                                                                            |                         |      |         |      |      |
|----------------------------------|--------------------------------------------------------------------------------------------|-------------------------|------|---------|------|------|
| Symbol                           | Conditions                                                                                 |                         | min. | typ.    | max. | Unit |
| Inverse diode                    |                                                                                            |                         |      |         |      |      |
| V <sub>F</sub> = V <sub>EC</sub> | I <sub>F</sub> = 300 A<br>V <sub>GE</sub> = 0 V<br>chipelevel                              | T <sub>j</sub> = 25 °C  |      | 1.40    | 1.76 | V    |
|                                  |                                                                                            | T <sub>j</sub> = 150 °C |      | 1.39    | 1.77 | V    |
| V <sub>F0</sub>                  | chipelevel                                                                                 | T <sub>j</sub> = 25 °C  |      | 1.04    | 1.24 | V    |
|                                  |                                                                                            | T <sub>j</sub> = 150 °C |      | 0.85    | 0.99 | V    |
| r <sub>F</sub>                   | chipelevel                                                                                 | T <sub>j</sub> = 25 °C  |      | 1.19    | 1.76 | mΩ   |
|                                  |                                                                                            | T <sub>j</sub> = 150 °C |      | 1.79    | 2.6  | mΩ   |
| I <sub>RRM</sub>                 | I <sub>F</sub> = 300 A                                                                     | T <sub>j</sub> = 150 °C |      | 313     |      | A    |
| Q <sub>rr</sub>                  | di/dt <sub>off</sub> = 5400 A/μs                                                           | T <sub>j</sub> = 150 °C |      | 31.5    |      | μC   |
| E <sub>rr</sub>                  | V <sub>GE</sub> = +15 /-7.5 V<br>V <sub>CC</sub> = 300 V                                   | T <sub>j</sub> = 150 °C |      | 6.4     |      | mJ   |
| R <sub>th(j-c)</sub>             | per diode                                                                                  |                         |      |         | 0.25 | K/W  |
| R <sub>th(c-s)</sub>             | per diode (λ <sub>grease</sub> =0.81 W/(m*K))                                              |                         |      | 0.044   |      | K/W  |
| R <sub>th(c-s)</sub>             | per diode, pre-applied phase change material                                               |                         |      | 0.041   |      | K/W  |
| Module                           |                                                                                            |                         |      |         |      |      |
| L <sub>CE</sub>                  |                                                                                            |                         |      | 15      |      | nH   |
| R <sub>CC'+EE'</sub>             | measured per switch                                                                        | T <sub>C</sub> = 25 °C  |      | 0.55    |      | mΩ   |
|                                  |                                                                                            | T <sub>C</sub> = 125 °C |      | 0.85    |      | mΩ   |
| R <sub>th(c-s)1</sub>            | calculated without thermal coupling                                                        |                         |      | 0.01074 |      | K/W  |
| R <sub>th(c-s)2</sub>            | including thermal coupling,<br>Ts underneath module<br>(λ <sub>grease</sub> =0.81 W/(m*K)) |                         |      | 0.018   |      | K/W  |
| R <sub>th(c-s)2</sub>            | including thermal coupling,<br>Ts underneath module, pre-applied<br>phase change material  |                         |      | 0.016   |      | K/W  |
| M <sub>s</sub>                   | to heat sink M6                                                                            |                         | 3    |         | 5    | Nm   |
| M <sub>t</sub>                   |                                                                                            | to terminals M6         | 2.5  |         | 5    | Nm   |
|                                  |                                                                                            |                         |      |         |      | Nm   |
| w                                |                                                                                            |                         |      |         | 325  | g    |



**GB**

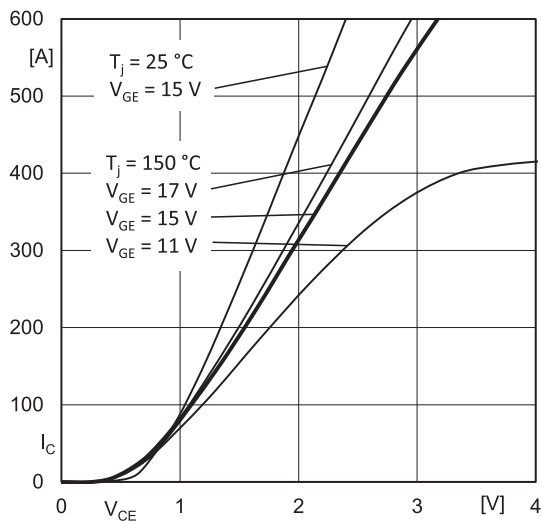


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'} + E_{E'}$

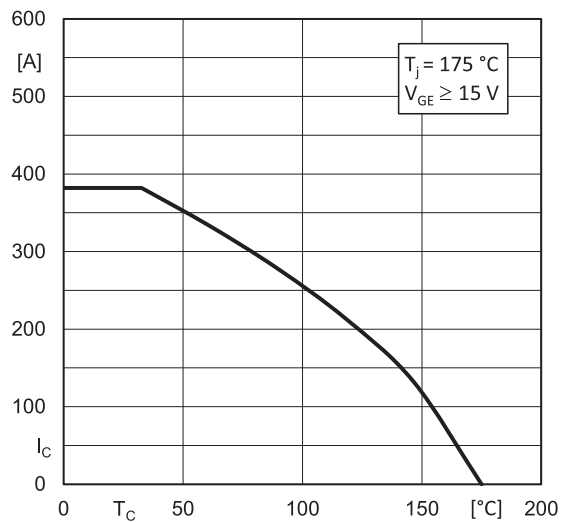


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

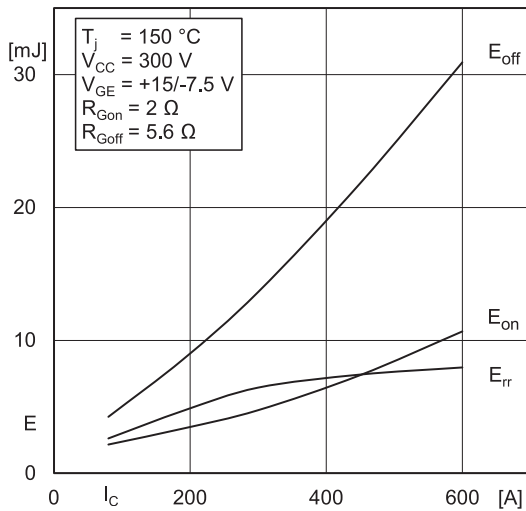


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

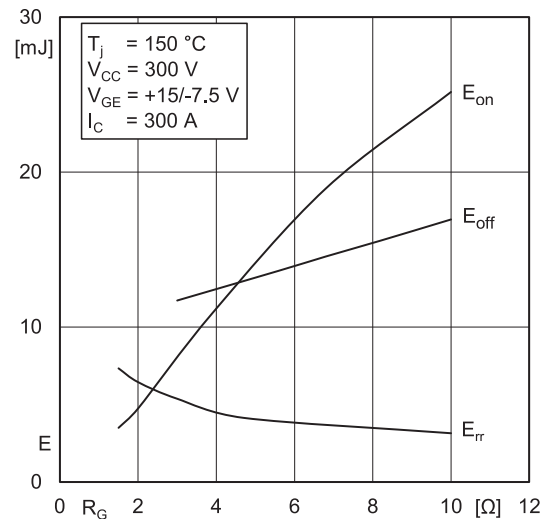


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

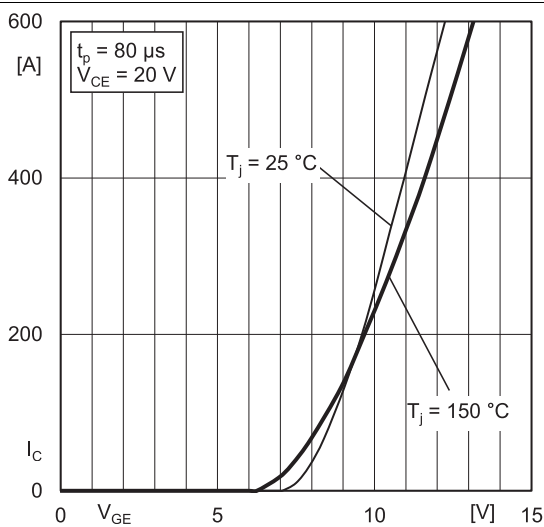


Fig. 5: Typ. transfer characteristic

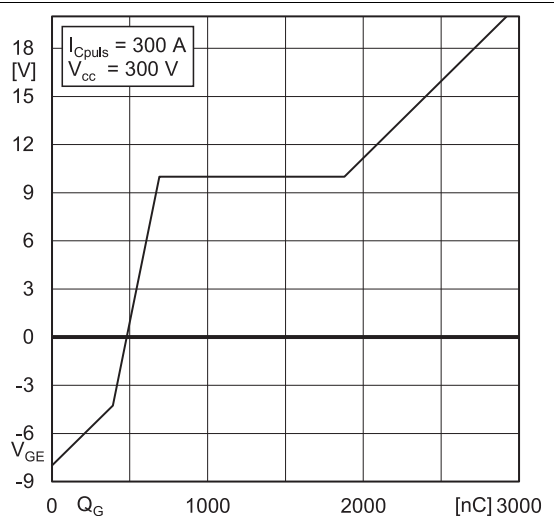


Fig. 6: Typ. gate charge characteristic

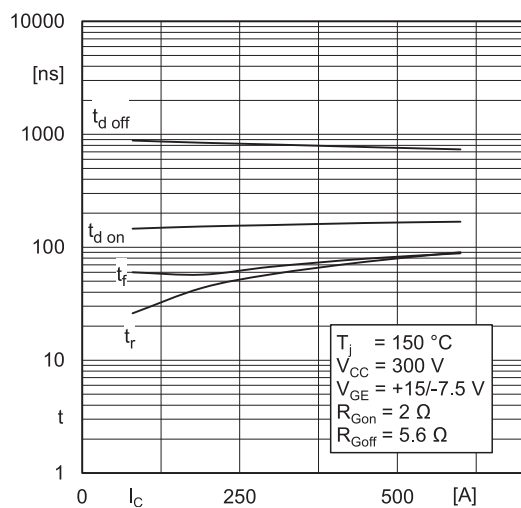


Fig. 7: Typ. switching times vs.  $I_C$

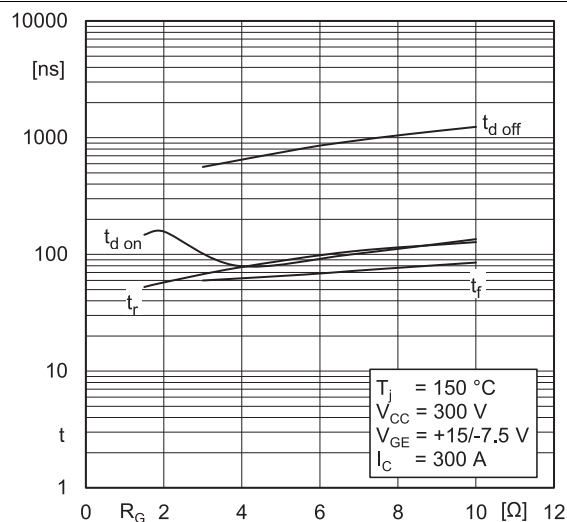


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

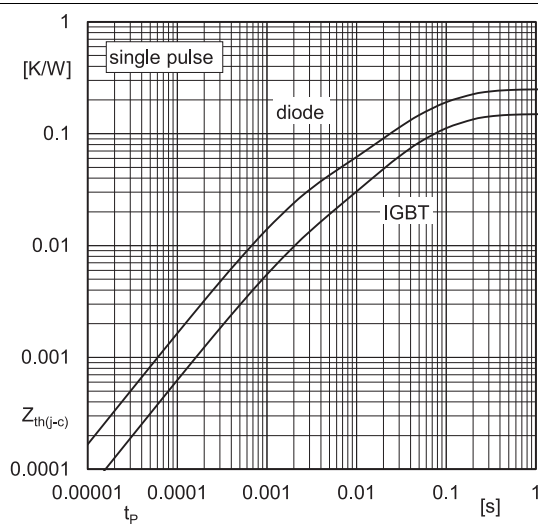


Fig. 9: Transient thermal impedance

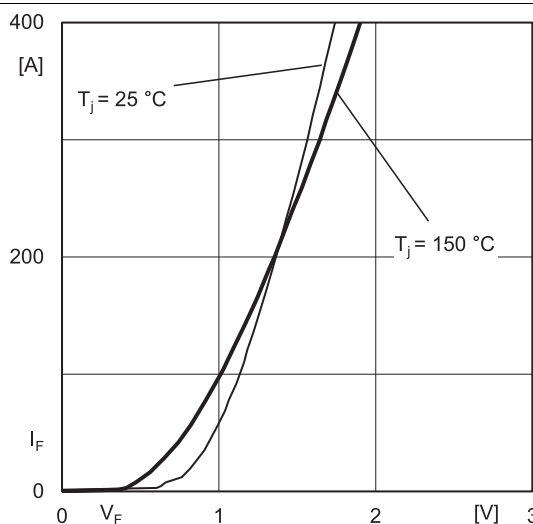


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC'}+EE'$

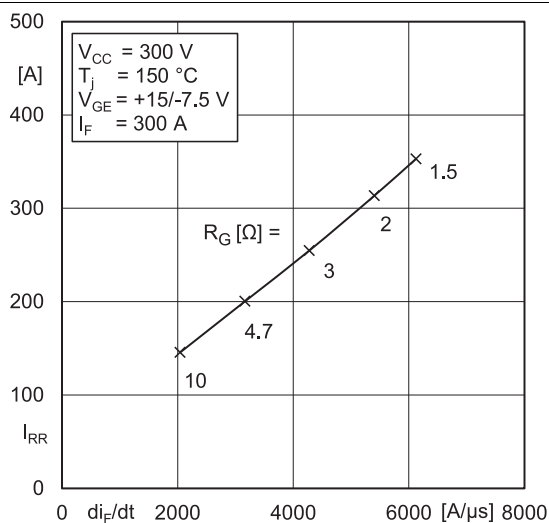


Fig. 11: Typ. CAL diode peak reverse recovery current

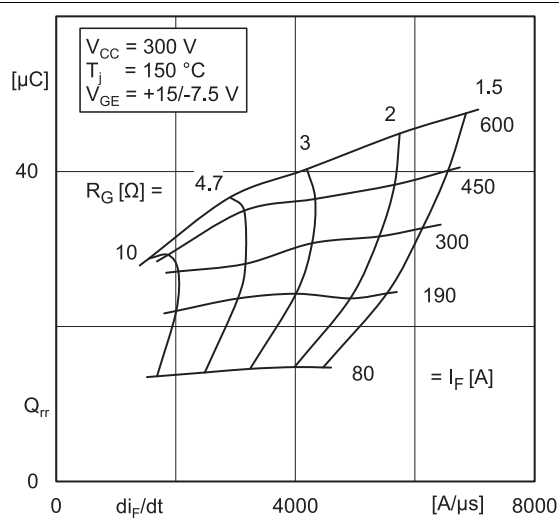
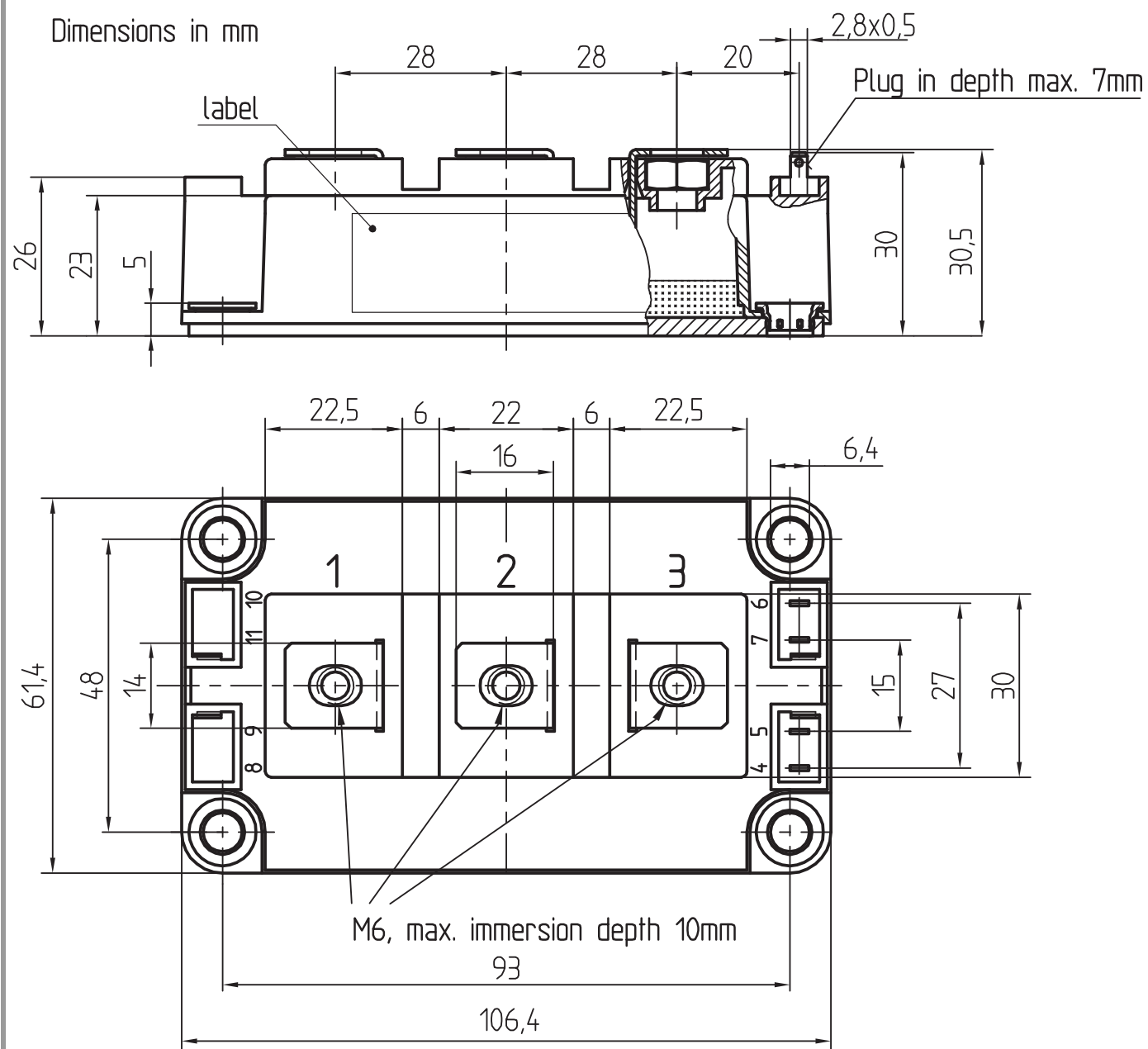
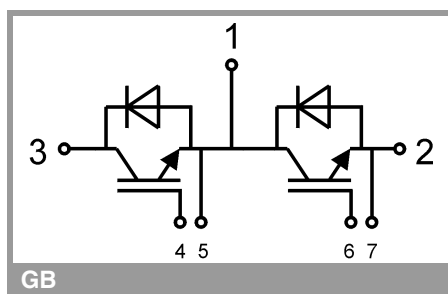


Fig. 12: Typ. CAL diode peak reverse recovery charge



General tolerance  $\pm 0,5$  mm

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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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